

Vishay Siliconix

RoHS COMPLIANT

N-Channel 30-V (D-S) MOSFET

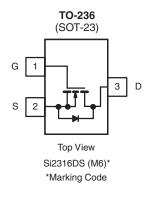
PRODUCT SUMMARY					
V _{DS} (V)	r _{DS(on)} (Ω)	$r_{DS(on)}(\Omega)$ $I_D(A)^a$			
30	0.050 at V _{GS} = 10 V	4.5	3.16 nC		
	0.080 at V _{GS} = 4.5 V	3.4	3.10110		

FEATURES

- TrenchFET[®] Power MOSFET
- PWM Optimized
- 100 % Rg tested

APPLICATIONS

- Battery Switch
- DC/DC Converter



Ordering Information: Si2316BDS-T1-E3 (Lead (Pb)-free)

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	30	v		
Gate-Source Voltage		V _{GS}	± 20	v	
	T _C = 25 °C		4.5		
Continuous Drain Current (T _J = 150 °C)	T _C = 70 °C		3.6		
	T _A = 25 °C	I _D	3.9 ^{b, c}		
	T _A = 70 °C		3.13 ^{b, c}	A	
Pulsed Drain Current		I _{DM}	20		
Continuous Source-Drain Diode Current	$T_{\rm C} = 25 ^{\circ}{\rm C}$ I _S		1.39		
Continuous Source-Drain Diode Current	T _A = 25 °C	'S	1.04 ^{b, c}		
	T _C = 25 °C		1.66		
Maximum Power Dissipation	T _C = 70 °C	P _D	1.06	w	
	T _A = 25 °C	'D	1.25 ^{b, c}	vv	
	T _A = 70 °C		0.8 ^{b, c}		
Operating Junction and Storage Temperature Range		T _J , T _{stq}	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, d}	\leq 5 sec	R _{thJA}	80	100	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	60	75		

Notes: a. Based on T_C = 25 °C.

b. Surface Mounted on 1" x 1" FR4 Board.

c. t = 5 sec. d. Maximum under Steady State conditions is 130 °C/W.



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MOSFET SPECIFICATIONS Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
Static	Gymbol		WIIII	- IVP	Max	
Drain-Source Breakdown Voltage	V _{DS}	V _{DS} = 0 V, I _D = 250 μA	30			V
V _{DS} Temperature Coefficient	ΔV _{DS} /T _J			23.92		mV/°C
V _{GS(th)} Temperature Coefficient	ΔV _{GS(th)} /T _J	I _D = 250 μA		5.2		
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250 μA	1		3	V
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			1	
		V_{DS} = 30 V, V_{GS} = 0 V, T_{J} = 55 °C			10	μA
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5$ V, V_{GS} = 10 V	20			Α
_	2(01)	V _{GS} = 10 V, I _D = 3.9 A		0.041	0.050	Ω
Drain-Source On-State Resistance ^a	r _{DS(on)}	V _{GS} = 4.5 V, I _D = 3.3 A		0.064	0.080	
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15V, I _D = 3.9 A		6		S
Dynamic ^b						1
Input Capacitance	C _{iss}			350		
Output Capacitance	C _{oss}	-		65		pF
Reverse Transfer Capacitance	C _{rss}	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, \text{ f} = 1 \text{ MHz}$		37		
	0	$V_{DS} = 15 \text{ V}, \text{ V}_{GS} = 10 \text{ V}, \text{ I}_{D} = 3.9 \text{ A}$		6.35	9.6	nC
Total Gate Charge	Qg			3.16	4.8	
Gate-Source Charge	Q _{gs}	V_{DS} = 15 V, V_{GS} = 4.5 V, I_{D} = 3.9 A		1.56		
Gate-Drain Charge	Q _{gd}			1.1		
Gate Resistance	Rg	f = 1 MHz		2.6	3.9	Ω
Turn-On Delay Time	t _{d(on)}			4.5	6.75	- ns
Rise Time	t _r	V_{DD} = 15 V, R_L = 4.8 Ω		11	16.5	
Turn-Off Delay Time	t _{d(off)}	$\text{I}_\text{D}\cong$ 3.13 A, V_GEN = 10 V, R_G = 1 Ω		12	18	
Fall Time	t _f			7	10.5	
Turn-On Delay Time	t _{d(on)}			20	30	- ns
Rise Time	t _r	V_{DD} = 15 V, R_L = 6.25 Ω		65	98	
Turn-Off Delay Time	t _{d(off)}	I_{D} = 2.4 A, V_{GEN} = 4.5 V, R_{G} = 1 Ω		11	17	
Fall Time	t _f			23	35	
Drain-Source Body Diode Characteristi	cs					
Continuous Source-Drain Diode Current	۱ _S	T _C = 25 °C			1.39	A
Pulse Diode Forward Current ^a	I _{SM}				20	
Body Diode Voltage	V _{SD}	I _S = 2.0 A		0.8	1.2	V
Body Diode Reverse Recovery Time	t _{rr}			10	15	ns
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = 2.0 A, di/dt = 100 A/μs, Τ _J = 25 °C		4	6	nC
Reverse Recovery Fall Time	t _a	$r_{\rm F} = 2.0$ Å, $u_{\rm r}u_{\rm c} = 100$ Å/µs, $r_{\rm J} = 20$ C		6.6		ns
Reverse Recovery Rise Time	t _b			3.5		

Notes:

a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %. b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

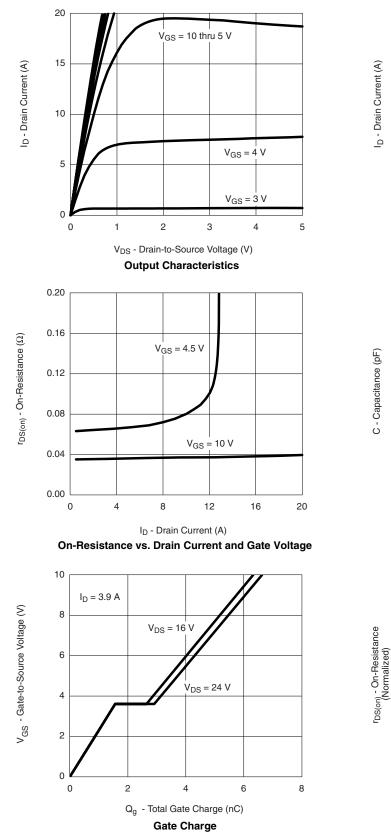


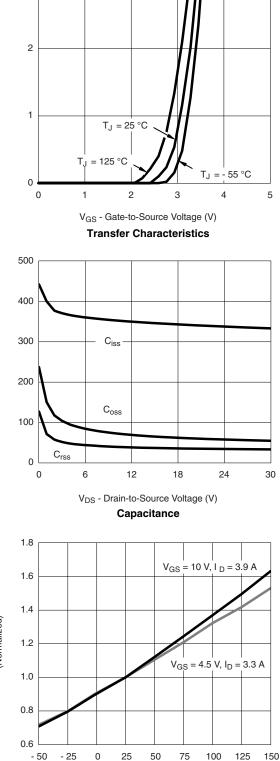
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Si2316BDS

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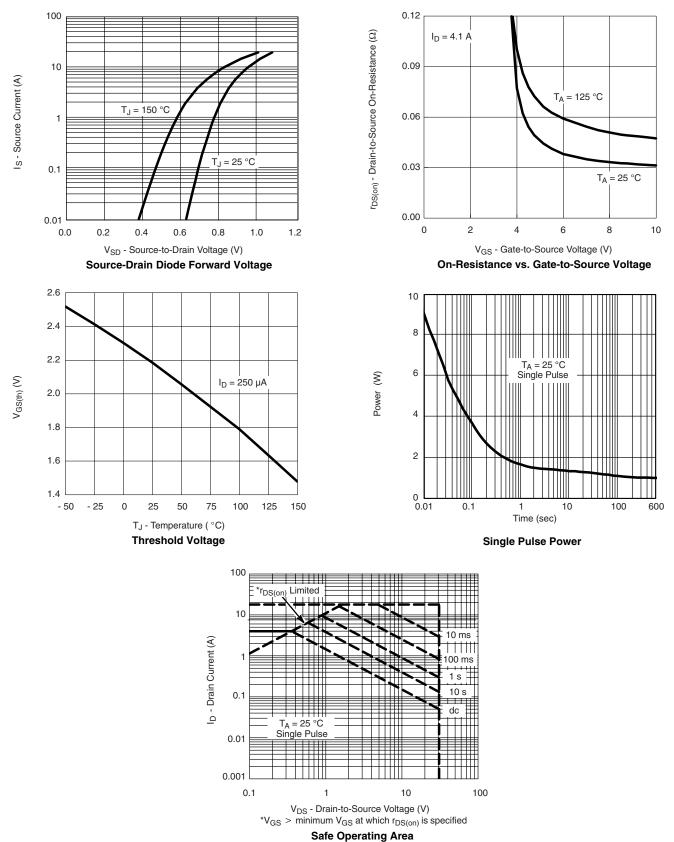


T_J - Junction Temperature (°C) On-Resistance vs. Junction Temperature

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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

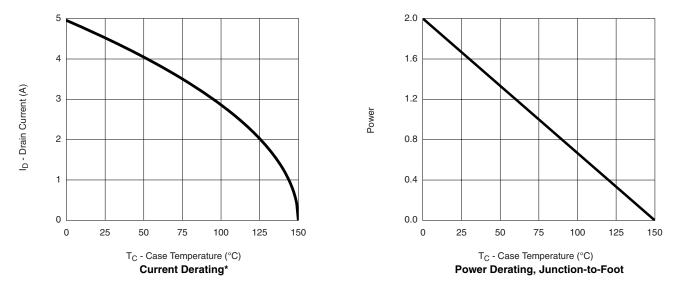




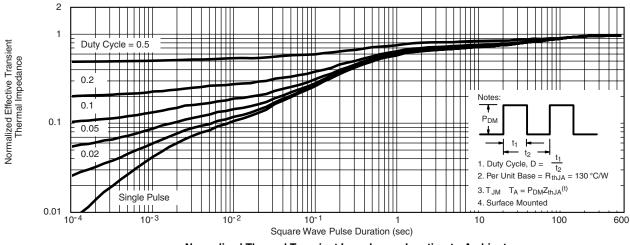


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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



*The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



Normalized Thermal Transient Impedance, Junction-to-Ambient

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see http://www.vishay.com/ppg?70445



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